

Optocoupler, Phototransistor Output, AC Input, With Base Connection

Features

- Guaranteed CTR Symmetry, 2:1 Maximum
- Bidirectional AC Input Industry Standard SOIC-8 Surface Mountable Package
- Standard Lead Spacing, .05 "
- · Available only on Tape and Reel (Conform to EIA Standard RS481A)

Agency Approvals

- UL File #E52744 System Code Y
- CSA 93751
- DIN EN 60747-5-2(VDE0884) DIN EN 60747-5-5 pending Available with Option 1
- FIMKO

Applications

Telecom applications ring detection

Description

The IL256A is an AC input phototransistor optocoupler. The device consists of two infrared emitters connected in reverse parallel and coupled to a silicon NPN phototransistor detector.

These circuit elements are constructed with a standard SOIC-8 foot print.

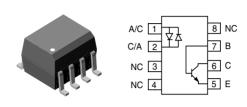
Absolute Maximum Ratings

T_{amb} = 25 °C, unless otherwise specified

Stresses in excess of the absolute Maximum Ratings can cause permanent damage to the device. Functional operation of the device is not implied at these or any other conditions in excess of those given in the operational sections of this document. Exposure to absolute Maximum Rating for extended periods of the time can adversely affect reliability.

Input

| Parameter | Test condition | Symbol | Value | Unit |
|----------------------------|----------------|-------------------|-------|-------|
| Forward continuous current | | ١ _F | 60 | mA |
| Power dissipation | | P _{diss} | 90 | mW |
| Derate linearly from 25 °C | | | 0.8 | mW/°C |



The product is well suited for telecom applications such as ring detection or off/on hook status, given its bidirectional LED input and guaranteed current transfer ratio (CTR) minimum of 20 % at $I_F = 10$ mA.

Order Information

117002

| Part | Remarks |
|---------|-----------------------------------|
| IL256AT | CTR > 20 %, Tape and reel, SOIC-8 |

For additional information on the available options refer to Option Information.

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Output

| Parameter | Test condition | Symbol | Value | Unit |
|-------------------------------------|----------------|-------------------|-------|-------|
| Collector-emitter breakdown voltage | | BV _{CEO} | 30 | V |
| Emitter-collector breakdown voltage | | BV _{ECO} | 5.0 | V |
| Collector-base breakdown voltage | | BV _{CBO} | 70 | V |
| Power dissipation | | P _{diss} | 150 | mW |
| Derate linearly from 25 °C | | | 2.0 | mW/°C |

Coupler

| Parameter | Test condition | Symbol | Value | Unit |
|--|----------------|------------------|---------------|-------|
| Total package dissipation (LED + detector) | | P _{tot} | 240 | mW |
| Derate linearly from 25 °C | | | 3.2 | mW/°C |
| Storage temperature | | T _{stg} | - 55 to + 150 | ۵° |
| Operating temperature | | T _{amb} | - 55 to + 100 | ۵° |
| Soldering time at 260 °C | | | 10 | Sec. |

Electrical Characteristics

T_{amb} = 25 °C, unless otherwise specified Minimum and maximum values are testing requirements. Typical values are characteristics of the device and are the result of engineering evaluation. Typical values are for information only and are not part of the testing requirements.

Input

| Parameter | Test condition | Symbol | Min | Тур. | Max | Unit |
|-----------------|---------------------------|----------------|-----|------|-----|------|
| Forward voltage | $I_F = \pm 10 \text{ mA}$ | V _F | | 1.2 | 1.5 | V |

Output

| Parameter | Test condition | Symbol | Min | Тур. | Max | Unit |
|-------------------------------------|-------------------------|-------------------|-----|------|-----|------|
| Collector-emitter breakdown voltage | I _C = 1.0 mA | BV _{CEO} | 30 | 50 | | V |
| Emitter-collector breakdown voltage | I _E = 100 μA | BV _{ECO} | 5.0 | 10 | | V |
| Collector-base breakdown voltage | I _C = 100 μA | BV _{CBO} | 70 | 90 | | V |
| Collector-emitter leakage current | V _{CE} = 10 V | I _{CEO} | | 5.0 | 50 | nA |

Coupler

| Parameter | Test condition | Symbol | Min | Тур. | Max | Unit |
|---|---|--------------------|------|------|-----|------------------|
| Saturation voltage, collector- emitter | $I_{\rm F} = \pm 16$ mA, $I_{\rm C} = 2.0$ mA | V _{CEsat} | | | 0.4 | V |
| Isolation voltage, input to output | | V _{ISO} | 3000 | | | V _{RMS} |

Current Transfer Ratio

| Parameter | Test condition | Symbol | Min | Тур. | Max | Unit |
|---|---|------------|-----|------|-----|------|
| DC Current Transfer Ratio | $I_{F} = \pm 10 \text{ mA}, V_{CE} = 5.0 \text{ V}$ | CTR_{DC} | 20 | | | % |
| Symmetry (CTR at + 10 mA)/ (CTR at -10 mA) | | | 0.5 | 1.0 | 2.0 | |



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Typical Characteristics (T_{amb} = 25 °C unless otherwise specified)

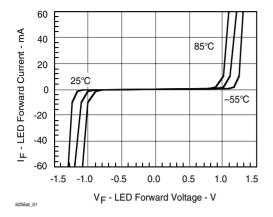


Fig. 1 LED Forward Current vs.Forward Voltage

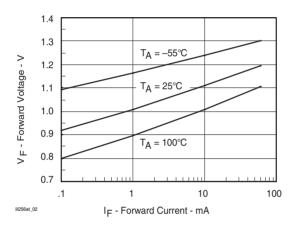


Fig. 2 Forward Voltage vs. Forward Current

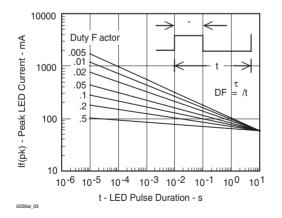


Fig. 3 Peak LED Current vs. Duty Factor, Tau

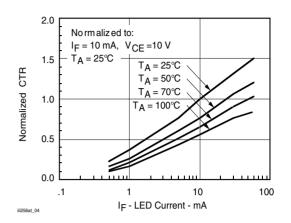
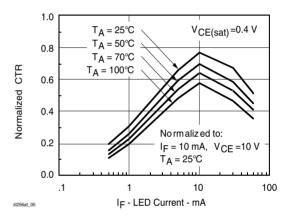
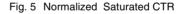


Fig. 4 Normalized CTR vs. I_F and T_{amb}





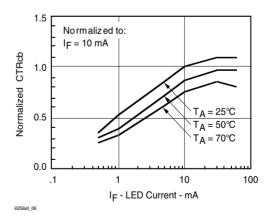


Fig. 6 Normalized CTR_{cb}

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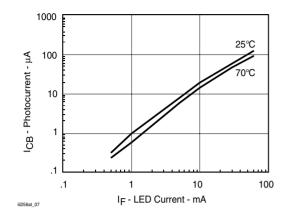


Fig. 7 Photocurrent vs. LED Current

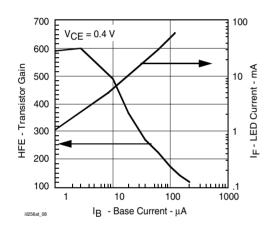


Fig. 8 Base Current vs. $\rm I_{F}$ and HFE

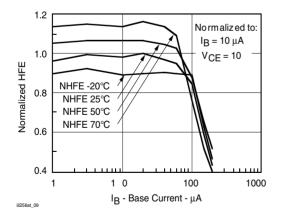


Fig. 9 Normalized HFE vs. Base Current and Temp.

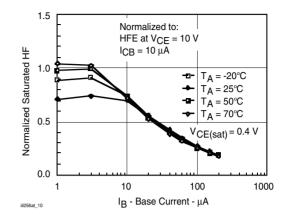


Fig. 10 Normalized Saturated HFE vs. Base Current

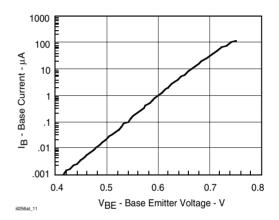


Fig. 11 Base Emitter Voltage vs. Base Current

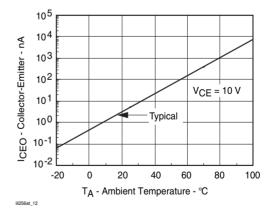


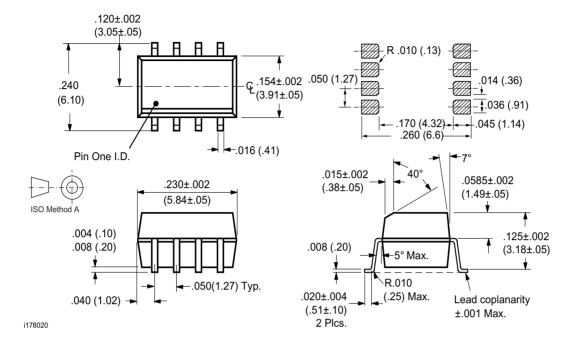
Fig. 12 Collector-Emitter Leakage Current vs.Temp.

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Package Dimensions in Inches (mm)





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Ozone Depleting Substances Policy Statement

It is the policy of Vishay Semiconductor GmbH to

- 1. Meet all present and future national and international statutory requirements.
- 2. Regularly and continuously improve the performance of our products, processes, distribution and operatingsystems with respect to their impact on the health and safety of our employees and the public, as well as their impact on the environment.

It is particular concern to control or eliminate releases of those substances into the atmosphere which are known as ozone depleting substances (ODSs).

The Montreal Protocol (1987) and its London Amendments (1990) intend to severely restrict the use of ODSs and forbid their use within the next ten years. Various national and international initiatives are pressing for an earlier ban on these substances.

Vishay Semiconductor GmbH has been able to use its policy of continuous improvements to eliminate the use of ODSs listed in the following documents.

- 1. Annex A, B and list of transitional substances of the Montreal Protocol and the London Amendments respectively
- 2. Class I and II ozone depleting substances in the Clean Air Act Amendments of 1990 by the Environmental Protection Agency (EPA) in the USA
- 3. Council Decision 88/540/EEC and 91/690/EEC Annex A, B and C (transitional substances) respectively.

Vishay Semiconductor GmbH can certify that our semiconductors are not manufactured with ozone depleting substances and do not contain such substances.

We reserve the right to make changes to improve technical design and may do so without further notice.

Parameters can vary in different applications. All operating parameters must be validated for each customer application by the customer. Should the buyer use Vishay Semiconductors products for any unintended or unauthorized application, the buyer shall indemnify Vishay Semiconductors against all claims, costs, damages, and expenses, arising out of, directly or indirectly, any claim of personal damage, injury or death associated with such unintended or unauthorized use.

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